S	earch	Notes	

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/659,886	ALKHATEEB ET AL.	
Examiner	Art Unit	
TAN TRINH	2684	

SEARCHED			
Class	Subclass	Date	Examiner
455	3.02	6/5/2006	π
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	6/5/2008	т	
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INTERPERENCE SEARCH	4/19/07	7.7.	
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